

Application/Control No.	Applicant(s)/Patent under Reexamination SHIN ET AL.	
Linh T. Nguyen	2627	

SEARCHED					
Class	Subclass	Date	Examiner		
369	112.12	12/8/2006	LN		
369	112.07	12/8/2006	LN		
369	112.04	12/18/2006	LN		
369	112.1	12/8/2006	LN		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
Interference Search on East.		12/8/2006	LN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Searched.	12/8/2006	LN		
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